







CSD13383F4 SLPS517C - DECEMBER 2014 - REVISED FEBRUARY 2022

## CSD13383F4 12 V N-Channel FemtoFET™ MOSFET

#### 1 Features

- Low on-resistance
- Ultra low  $Q_g$  and  $Q_{gd}$
- Ultra-small footprint (0402 case size)
  - 1.0 mm × 0.6 mm
- Low profile
  - 0.36 mm height
- Integrated ESD protection diode
  - Rated >2 kV HBM
  - Rated >2 kV CDM
- Lead and halogen free
- RoHS compliant

## 2 Applications

- Optimized for load switch applications
- Optimized for general purpose Switching **Applications**
- Single-cell battery applications
- Handheld and mobile applications

# 3 Description

This 37 mΩ, 12 V N-channel FemtoFET™ MOSFET technology is designed and optimized to minimize the footprint in many handheld and mobile applications. This technology is capable of replacing standard small signal MOSFETs while providing at least a 60% reduction in footprint size.

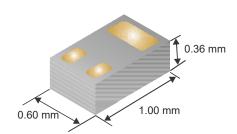


Figure 3-1. Typical Part Dimensions

#### **Product Summary**

T <sub>A</sub> = 25°	С	TYPICAL VA	LUE	UNIT
V <sub>DS</sub>	Drain-to-Source Voltage	12		٧
Qg	Gate Charge Total (4.5 V)	2.0	2.0	
Q <sub>gd</sub>	Gate Charge Gate-to-Drain	0.6	0.6	
В	Drain-to-Source On-Resistance	V <sub>GS</sub> = 2.5 V	53	mΩ
R <sub>DS(on)</sub>	Dialii-to-Source Oil-Resistance	V <sub>GS</sub> = 4.5 V	37	11122
V <sub>GS(th)</sub>	Threshold Voltage	1.0		V

## **Ordering Information**

DEVICE <sup>(1)</sup>	QTY	MEDIA	PACKAGE	SHIP
CSD13383F4	3000	7-Inch	Femto (0402) 1.0 mm ×	Tape and
CSD13383F4T	250	Reel	0.6 mm SMD Lead Less	Reel

For all available packages, see the orderable addendum at the end of the data sheet.

### **Absolute Maximum Ratings**

T <sub>A</sub> = 25	°C	VALUE	UNIT	
V <sub>DS</sub>	Drain-to-Source Voltage	12	V	
V <sub>GS</sub>	Gate-to-Source Voltage	±10	V	
I <sub>D</sub>	Continuous Drain Current <sup>(1)</sup>	2.9	Α	
I <sub>DM</sub>	Pulsed Drain Current <sup>(1)</sup> (2)	18.5	Α	
	Continuous Gate Clamp Current	25	mA	
l <sub>G</sub>	Pulsed Gate Clamp Current <sup>(1)</sup> (2)	250	IIIA	
PD	Power Dissipation	500	mW	
ESD	Human Body Model (HBM)	2	kV	
Rating	Charged Device Model (CDM)	2	kV	
T <sub>J</sub> , T <sub>stg</sub>	Operating Junction Temperature Storage Temperature	-55 to 150	°C	
E <sub>AS</sub>	Avalanche Energy, single pulse $I_D$ = 6.7, L = 0.1 mH, $R_G$ = 25 $\Omega$	2.2	mJ	

- Typical  $R_{\theta JA} = 250^{\circ} C/W$ .
- Pulse duration ≤100 µs, duty cycle ≤1%.

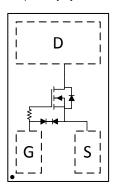


Figure 3-2. Top View



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# **4 Revision History**

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

CI	hanges from Revision B (December 2017) to Revision C (February 2022)	Page
•	Changed ultra-low profile bullet from 0.35 mm to 0.36 mm in height	1
•	Updated ultra-low profile image height from 0.35 mm to 0.36 mm	1
•	Changed ultra-low profile image height from 0.35 mm to 0.36 mm	8
	Added FemtoFET Surface Mount Guide note	

C	hanges from Revision A (January 2016) to Revision B (December 2017)	Page
•	Changed I <sub>DM</sub> value From: 27 A To: 18.5 A in the <i>Absolute Maximum Ratings</i> table	
•	Updated Figure 5-1.	
•	Updated Figure 5-10 using Typ R <sub>0JA</sub> = 250°C/W.	3
	Updated all mechanical drawings, increased the size of the pads in the Section 7.3 section	



# **5 Specifications**

## **5.1 Electrical Characteristics**

(T<sub>A</sub> = 25°C unless otherwise stated)

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
STATIC	CHARACTERISTICS					
BV <sub>DSS</sub>	Drain-to-source voltage	V <sub>GS</sub> = 0 V, I <sub>DS</sub> = 250 μA	12			V
I <sub>DSS</sub>	Drain-to-source leakage current	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 9.6 V			1	μΑ
I <sub>GSS</sub>	Gate-to-source leakage current	V <sub>DS</sub> = 0 V, V <sub>GS</sub> = 10 V			10	μΑ
V <sub>GS(th)</sub>	Gate-to-source threshold voltage	$V_{DS} = V_{GS}, I_{DS} = 250 \mu A$	0.70	1.00	1.25	V
D	Drain to course on registence	V <sub>GS</sub> = 2.5 V, I <sub>DS</sub> = 0.5 A		53	65	mΩ
$R_{DS(on)}$	Drain-to-source on-resistance	V <sub>GS</sub> = 4.5 V, I <sub>DS</sub> = 0.5 A		37	44	mΩ
g <sub>fs</sub>	Transconductance	V <sub>DS</sub> = 6 V, I <sub>DS</sub> = 0.5 A		5.4		S
DYNAM	IC CHARACTERISTICS	·	<u>'</u>			
C <sub>iss</sub>	Input capacitance			224	291	pF
C <sub>oss</sub>	Output capacitance	$V_{GS} = 0 \text{ V}, V_{DS} = 6 \text{ V},$ $f = 1 \text{ MHz}$		68	88	pF
C <sub>rss</sub>	Reverse transfer capacitance	J		47	61	pF
R <sub>G</sub>	Series gate resistance			240		Ω
Qg	Gate charge total (4.5 V)			2.0	2.6	nC
Q <sub>gd</sub>	Gate-to-source threshold voltage  Drain-to-source on-resistance  Transconductance  CHARACTERISTICS  Input capacitance  Quety transfer capacitance  Geries gate resistance  Gate charge total (4.5 V)  Gate charge gate-to-drain  Gate charge gate-to-source  Gate charge at V <sub>th</sub> Dutput charge  Turn on delay time  Fall time	V = 0.V L = 0.5.A		0.6		nC
Q <sub>gs</sub>	Gate charge gate-to-source	$V_{DS} = 6 \text{ V}, I_{DS} = 0.5 \text{ A}$		0.4		nC
Q <sub>g(th)</sub>	Gate charge at V <sub>th</sub>			0.1		nC
Q <sub>oss</sub>	Output charge	V <sub>DS</sub> = 6 V, V <sub>GS</sub> = 0 V		0.9		nC
t <sub>d(on)</sub>	Turn on delay time			46		ns
t <sub>r</sub>	Rise time	V <sub>DS</sub> = 6 V, V <sub>GS</sub> = 4.5 V,		122		ns
t <sub>d(off)</sub>	Turn off delay time	$I_{DS} = 0.5 \text{ A}, R_G = 2 \Omega$		250		ns
t <sub>f</sub>	Fall time			290		ns
DIODE (	CHARACTERISTICS	•	<u> </u>			
V <sub>SD</sub>	Diode forward voltage	I <sub>SD</sub> = 0.5 A, V <sub>GS</sub> = 0 V		0.7	1.0	V

## **5.2 Thermal Information**

(T<sub>A</sub> = 25°C unless otherwise stated)

	THERMAL METRIC	MIN	TYP	MAX	UNIT
	Junction-to-ambient thermal resistance <sup>(1)</sup>		90		°C/W
	Junction-to-ambient thermal resistance <sup>(2)</sup>		250		C/VV

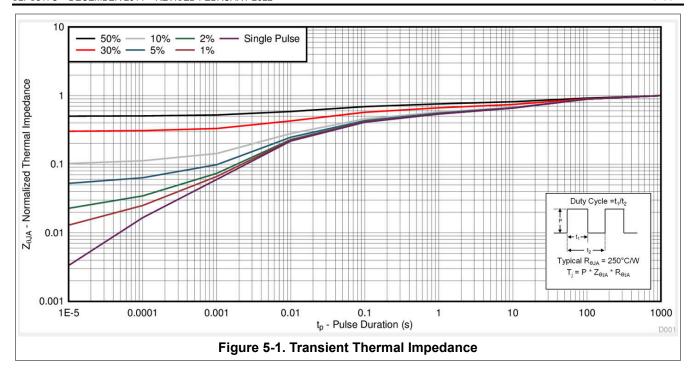
<sup>(1)</sup> Device mounted on FR4 material with 1 inch<sup>2</sup> (6.45 cm<sup>2</sup>), 2 oz. (0.071 mm thick) Cu.

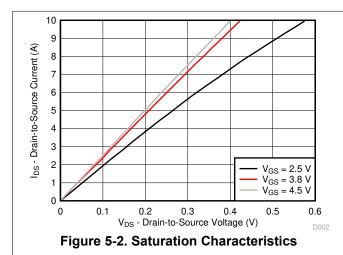
# **5.3 Typical MOSFET Characteristics**

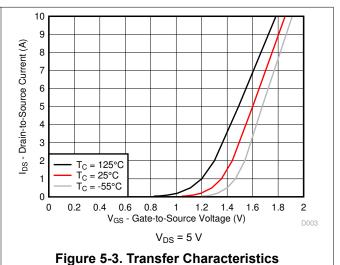
(T<sub>A</sub> = 25°C unless otherwise stated)

<sup>(2)</sup> Device mounted on FR4 material with minimum Cu mounting area.

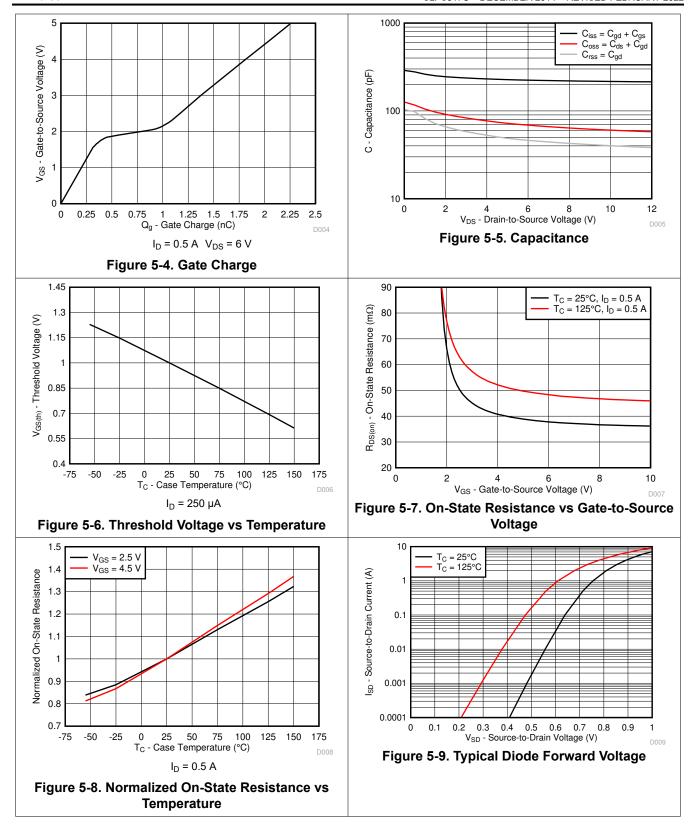


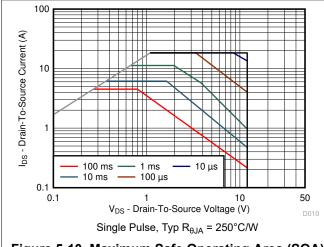


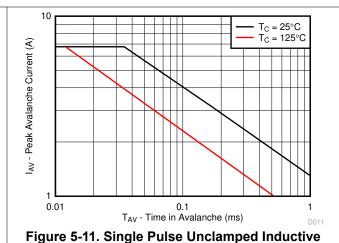












**Switching** 

A. 1.1941.00

Figure 5-10. Maximum Safe Operating Area (SOA)

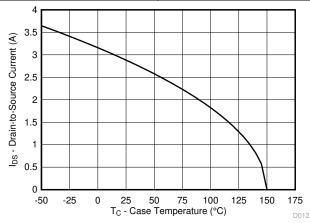


Figure 5-12. Maximum Drain Current vs Temperature

# **6 Device and Documentation Support**

# **6.1 Support Resources**

TI E2E<sup>™</sup> support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

Linked content is provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

#### 6.2 Trademarks

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### 6.3 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

## 6.4 Glossary

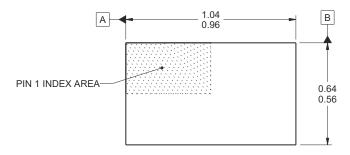
TI Glossary

This glossary lists and explains terms, acronyms, and definitions.

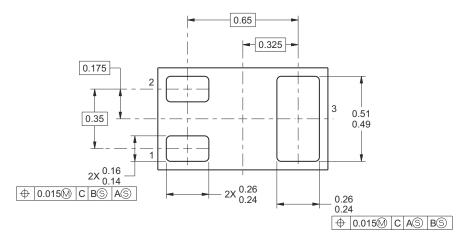
# 7 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

### 7.1 Mechanical Dimensions



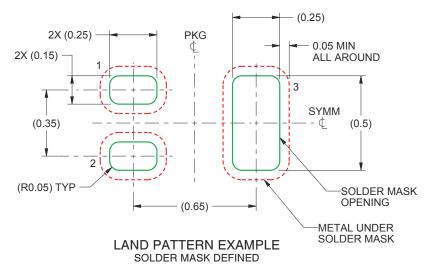




- All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
- B. This drawing is subject to change without notice.
- C. This package is a Pb-free bump design. Bump finish may vary. To determine the exact finish, refer to the device data sheet or contact a local TI representative.

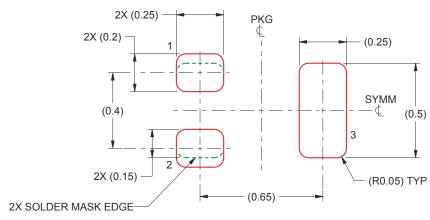


# 7.2 Recommended Minimum PCB Layout



- A. All dimensions are in millimeters.
- B. For more information, see FemtoFET Surface Mount Guide (SLRA003D).

### 7.3 Recommended Stencil Pattern



SOLDER PASTE EXAMPLE

- A. All dimensions are in millimeters.
- B. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

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#### PACKAGING INFORMATION

Orderable part number	Status	Material type	Package   Pins	Package qty   Carrier	RoHS	Lead finish/ Ball material	MSL rating/ Peak reflow	Op temp (°C)	Part marking (6)
	(.,	(=)			(0)	(4)	(5)		(0)
CSD13383F4	Active	Production	PICOSTAR (YJC)   3	3000   LARGE T&R	Yes	NIAU	Level-1-260C-UNLIM	-55 to 150	GC
CSD13383F4.B	Active	Production	PICOSTAR (YJC)   3	3000   LARGE T&R	Yes	NIAU	Level-1-260C-UNLIM	-55 to 150	GC
CSD13383F4T	Active	Production	PICOSTAR (YJC)   3	250   SMALL T&R	Yes	NIAU	Level-1-260C-UNLIM	-55 to 150	GC
CSD13383F4T.B	Active	Production	PICOSTAR (YJC)   3	250   SMALL T&R	Yes	NIAU	Level-1-260C-UNLIM	-55 to 150	GC

<sup>(1)</sup> Status: For more details on status, see our product life cycle.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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<sup>(3)</sup> RoHS values: Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

<sup>(4)</sup> Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

<sup>(5)</sup> MSL rating/Peak reflow: The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

<sup>(6)</sup> Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

# **PACKAGE MATERIALS INFORMATION**

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## TAPE AND REEL INFORMATION





A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



#### \*All dimensions are nominal

Device		Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
CSD13383F4	ICOSTAF	YJC	3	3000	180.0	8.4	0.7	1.1	0.46	4.0	8.0	Q2
CSD13383F4T	ICOSTAF	YJC	3	250	180.0	8.4	0.7	1.1	0.46	4.0	8.0	Q2

**PACKAGE MATERIALS INFORMATION** 

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### \*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
CSD13383F4	PICOSTAR	YJC	3	3000	182.0	182.0	20.0
CSD13383F4T	PICOSTAR	YJC	3	250	182.0	182.0	20.0

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Last updated 10/2025